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ATTORNEY DOCKET NO. FIRST NAMED APPLICANT APPLICATION NUMBER FILING DATE 091 847084 **EXAMINER** PAPER NUMBER 3635 **DATE MAILED:** INTERVIEW SUMMARY All participants (applicant, applicant's representative, PTO personnel): 30102 Sate of Interview Type: Telephonic Personal (copy is given to applicant applicant's representative). Agreement was reached. was not reached. Claim(s) discussed: Identification of prior art discussed: Description of the general nature of what was agreed to if an agreement was reached, or any other comments: (A fuller description, if necessary, and a copy of the amendments, if available, which the examiner agreed would render the claims allowable must be attached. Also, where no copy of the amendments which would render the claims allowable is available, a summary thereof must be attached.) 1. It is not necessary for applicant to provide a separate record of the substance of the interview. Unless the paragraph above has been checked to indicate to the contrary. A FORMAL WRITTEN RESPONSE TO THE LAST OFFICE ACTION IS NOT WAIVED AND MUST INCLUDE THE SUBSTANCE OF THE INTERVIEW. (See MPEP Section 713.04). If a response to the last Office action has are ready been filed, APPLICANT IS GIVEN ONE MONTH FROM THIS INTERVIEW DATE TO FILE A STATEMENT OF THE SUBSTANCE OF THE INTERVIEW. 2. Usince the Examiner's interview summary above (including any attachments) reflects a complete response to each of the objections, rejections and requirements that may be present in the last Office action, and since the claims are now allowable, this cr mpleted form is considered to fulfill the response requirements of the last Office action. Applicant is not relieved from providing a separate record of the interview unless box 1 above is also checked. Examiner Note: You must sign this form unless it is an attachment to another form. FORM PTOL-413 (REV.1-96) Carl D. Friedman Supervisory Patent Examiner